# **Special Issue**

# Vulnerability Analysis and Adversarial Learning

## Message from the Guest Editors

This Special Issue focuses on the vulnerability analysis of information systems, especially intelligent systems. This includes:

- Information system vulnerability analysis;
- Vulnerability analysis theory and methods;
- Machine learning for vulnerability analysis;
- Vulnerability analysis of Al algorithms, models, systems;
- Formal theory for adversarial leaning;
- Evaluation metrics for adversarial learning;
- Program and binary analysis;
- Trustworthy machine learning and Al;
- Privacy-preserving machine learning.

## **Guest Editors**

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## Deadline for manuscript submissions

closed (30 June 2024)



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## Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

#### Editor-in-Chief

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